

Search Notes

Application/Control No.

10/803,274

Examiner

Hau V. Phan

Applicant(s)/Patent under
Reexamination

KATO ET AL.

Art Unit

3618

SEARCHED

Class	Subclass	Date	Examiner
180	68.1 68.2 68.3	8/27/2007	HP
	908		
	788		
	337		
	215		
	258		
	371		
296	65.08	8/27/2007	HP
	63		
	65.01		
123	184.47	8/27/2007	HP
	184.53		
	41.65		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR